

## **UNIVERSITI PUTRA MALAYSIA**

# ELECTROCHEMICAL SYNTHESIS OF TIN SULPHIDE IN AQUEOUS MEDIA

**ARNIZA GHAZALI** 

FSAS 2000 42



## ELECTROCHEMICAL SYNTHESIS OF TIN SULPHIDE IN AQUEOUS MEDIA

By

#### ARNIZA GHAZALI

Thesis Submitted in Fulfilment of the Requirement for the Degree of Master of Science in the Faculty of Science and Environmental Studies
Universiti Putra Malaysia

October 2000



Abstract of thesis presented to the Senate of Universiti Putra Malaysia in fulfilment of the requirement for the degree of Master of Science

## ELECTROCHEMICAL SYNTHESIS OF TIN SULPHIDE IN AQUEOUS MEDIA

By

#### **ARNIZA GHAZALI**

#### October 2000

Chairman : Associate Professor Zulkarnain Zainal, Ph. D.

Faculty: Science and Environmental Studies

Chalcogenide semiconductor of the type tin sulphide or stannous sulphide (SnS) has been synthesised in aqueous media under the presence and absence of EDTA complexing agent. It was found that electrodeposition performed in the presence of EDTA is more reproducible, better adhered to titanium substrate, more leveled, more crystalline and offers better photoconductivity properties in comparison to electrodeposition carried out without EDTA. These were determined by means of Energy Dispersive Analysis of X-ray (EDAX), Scanning Electron Microscopy (SEM), X-ray Diffraction (XRD), UV-visible Spectroscopy, Linear Scan Photovoltammetry (LSPV) and in special cases, X-ray Photoelectron Spectroscopy (XPS). The main improvement in photoconductivity property which is a basic requirement for any solar energy materials and semiconductor was due



to factors that stem from good adhesion, crystallinity, surface coverage and composition.

Optimisation of the electrodeposition condition was the prerequisite of synthesising an outstanding SnS quality. In the optimisation study, the optimum amount of thiosulphate, EDTA and tin source (stannous ions) has been determined based upon the degree of reproducibility of Sn/S values from analysis of stoichiometry (via EDAX) and degree of reproducibility of deposits quantity (up to XRD detection limit for SnS deduction) at a fixed deposition time. optimum deposition potential of -0.7V (vs. SCE) was clear cut from microscopic analysis by means of scanning electron micrographs and quantification by way of EDAX. Under the optimum condition, an average Sn/S found from the study was  $1.12 \pm 0.05$ , which is within the expected stoichiometry found in literature. The average energy gap estimated on samples prepared on ITO substrate was 1.29 ± 0.29 eV for a direct optical transition and 0.74 ± 0.20 eV for indirect optical transition. In terms of proportion, this correlates with an advanced study on SnS property via valence band spectra by Ettema et al. published in Physical Review B, 1992, 46(12): 7363-7386, which reported the optical transitions to be 1.39 eV for direct transition and 0.2-0.4 eV for indirect transition.



Examination of the effect of sodium dodecylsulphate (SDS) on the electrodeposit shows a significant adverse effect on the electrodeposits. SDS was suspected to cause electrode poisoning and had resulted in raise of pH, which was non favourable for cathodic electrodeposition of SnS.

As in the case of tartaric acid, however, the leveling effect expected of it might be insignificant and this could have been the masking effect of EDTA. To ascertain the slight enhancement of crystal growth following addition of tartaric acid into the electrodeposition bath, further investigation may be required.



Abstrak tesis yang dikemukakan kepada Senat Universiti Putra Malaysia sebagai memenuhi keperluan untuk ijazah Master Sains.

## SINTESIS ELEKTROKIMIA TIMAH SULFIDA DI DALAM LARUTAN AKUEUS

#### Oleh

#### ARNIZA GHAZALI

#### Oktober 2000

Pengerusi : Profesor Madya Zulkarnain Zainal, Ph. D.

Fakulti : Sains dan Alam Sekitar

Semikonduktor kalkogenida, timah sulfida (SnS), telah disintesis di dalam larutan akueus dengan kehadiran dan tanpa kehadiran agen pengkompleks EDTA. Elektroenapan, yang dilakukan dengan kehadiran EDTA didapati mempunyai kebolehulangan yang lebih baik, di mana enapan dapat melekat pada titanium dengan lebih kuat, lebih rata, mempunyai kehabluran yang lebih baik dan mempamerkan sifat fotokonduksi yang lebih baik. Ini telah diperhatikan daripada analisis penyerakan tenaga sinaran-X (EDAX), mikroskopi elektron imbasan (SEM), pembelauan sinaran-X (XRD), spektroskopi ultra lembayung nampak (UV-visible), imbasan linear fotovoltametri (LSPV), dan di dalam kes-kes tertentu, spektroskopi fotoelektron sinar-X (XPS). Penigkatan dalam fotokonduksi yang merupakan satu sifat asas penting bagi peranti sel suria atau semikonduktor,



telah berjaya dicapai hasil daripada penambahbaikan daya lekatan, kehabluran, pelitupan permukaan dan komposisi.

Pengoptimuman pengelektroenapan adalah perlu bagi mendapatkan SnS yang berkualiti. Amaun optimum bagi tiosulfat, EDTA dan ion timah telah ditentukan berdasarkan pemerhatian kepada darjah keterulangan pada nisbah Sn/S daripada analisis stoikiometri (daripada EDAX), daya lekatan kepada substrat titanium, kehabluran dan sifat fotokonduksi yang baik. Keupayaan pengelektroenapan -0.7 V (terhadap SCE) telah dipilih keupayaan optimum berdasarkan mikroskopi elektron imbasan dan stoikiometri. Enapan yang dihasilkan pada keadaan optima ini menghasilkan nisbah stoikiometri pada nilai 1.12 ± 0.05 Sn/S, iaitu terlingkung di dalam julat nilai Sn/S yang boleh diterimapakai. Nilai luang tenaga, Eg bagi enapan yang disediakan di atas ITO di bawah keadaan optima ini ialah 1.29 ± 0.29 eV bagi peralihan terus dan 0.74 ± 0.20 eV bagi peralihan tidak terus. Ini bersesuaian dengan yang dilaporkan oleh Ettema et al. pada tahun 1992 di dalam jurnal Physical Review B, jilid 46, nombor 12, yang menjumpai jurang tenaga bagi peralihan terus 1.39 eV dan bagi peralihan tidak terus 0.2-0.4 eV.



Kehadiran bahan aktif permukaan SDS didapati menunjukkan kesan negatif kepada pengelektroenapan SnS. SDS tidak membantu pengelektroenapan sebaliknya menyebabkan keracunan elektrod. Keracunan ini dijangka berpunca daripada peningkatan pH, yang tidak sesuai untuk pengelektroenapan SnS.

Keupayaan asid tartarik untuk meratakan permukaan tidak dapat dilihat dengan jelas dan ini mungkin disebabkan kesan kehadiran EDTA di dalam larutan pengelektroenapan. Penambahan saiz yang dapat dilihat pada hablur menunjukkan kemungkinan asid tartarik mampu meningkatkan kadar pengelektroenapan. Kajian lanjut diperlukan bagi melihat kesan ini dengan lebih terperinci.



#### **ACKNOWLEDGEMENTS**

I wish to thank the Chairman of the M. Sc. project, Assoc. Prof. Dr Zulkarnain Zainal for his continuous assistance and motivation, without which this project might not have come to completion. I like to also acknowledge the help and guidance from my co-supervisors; Assoc. Prof. Dr Mohd Zobir Mohd Hussein and Assoc. Prof. Dr Anuar Kassim.

Also worthy of acknowledgement, are the staff of Department of Chemistry (UPM), Puan Aminah, Mr Ho and Cik Azilah of Veterinary Department (UPM), the technicians at XRD laboratory of Department of Geology (UKM), Assoc. Prof. Dr Hamzah of Department of Geology (UKM) and Prof. Ambar Yarmo of Department of Materials and Applied Sciences (UKM).

Among others who deserve of this acknowledgement are my respected parents and siblings who had been a constant push when I had oftentimes wanted to quit. I also wish to thank an old friend, Khairul Niza Abdul Razak for popping in from time to time, reminding of this long-awaited task to be completed.



It is a must for me to thank my husband who had been so understanding and supportive during this course of study and who had made the M. Sc. thesis write-up enjoyable and challenging at the same time. Also to be acknowledged are the friends of my husband at School of Physics, Universiti Sains Malaysia for their technical assistance.

Finally, I must thank all the kind help of the staff at GSO, Universiti Putra Malaysia. It is the help of you people that makes graduating possible.

Thanking Allah, the Cherisher and the Sustainer of the Universe, for He is the Best of Helpers.



### **TABLE OF CONTENTS**

		Page
ABSTRAG	CT	ii
ABSTRAI	K	v
ACKNOV	VLEDGMENTS	viii
<b>APPROV</b>	AL	X
<b>DECLAR</b>	ATION FORM	xi
	ΓABLES	xvi
LIST OF	FIGURES	xviii
LIST OF	PLATES	xxi
LIST OF A	ABBREVIATIONS	xxii
CHAPTE	R	
I	INTRODUCTION	1
П	LITERATURE REVIEW	6
	Semiconductors	6
	Band Model of Solids	6
	Band Model of Semiconductors	7
	Conductivity Type in Extrinsic Semiconductor	10
	Transition Type	12
	Semiconductor Varieties	15
	Commercialisation Prospects	16
	Phase Transition in Tin Chalcogenides	19
	α and β Transition in Tin Sulphide	21
	Chemical Solution Process	26
	Electrodeposition vs. Electroless Deposition	27
	Desirability of Electrodeposition	29
	Anodic and Cathodic Electrodeposition	30
	Electrodeposition in Aqueous Media	31
	Other Works on Deposition of SnS	33
III.	MATERIALS AND METHODOLOGY	42
	Cell	42 44
	Electrodes Working Electrode	
	Working Electrode	44
	Reference Electrode	46 47
	Auxillary Electrode	
	Electrodeposition Characterisation of Danasita	47 51
	Characterisation of Deposits	51
	Energy Dispersive Analysis of X-ray (EDAX)	51



	Photoelectrochemical Study (PEC)	56
	Scanning Electron Microscopy (SEM)	57
	X-ray Diffraction (XRD)	61
	X-ray Photoelectron Spectroscopy (XPS)	63
	UV-Visible Spectroscopy	65
IV	RESULTS AND DISCUSSION	68
	Optimisation	68
	Transient in Thiosulphate Concentration	69
	Transient in Stannous Ion Concentration	76
	Transient in Sn-EDTA Complex Concentration	82
	Transient in EDTA Concentration	88
	Transient in Electrodeposition Potential	92
	Photoresponse and the Optimum Condition Overall	99
	Electrosynthesis of SnS With and Without EDTA	103
	Analysis of Stoichiometry	103
	Morphology	104
	Optical Property	110
	Structural Analysis	113
	Photoactivity	115
	Adhesion	116
	Bath Longevity	116
	Effect of Tartaric Acid and Sodium Dodecyl Sulphate (SDS) on the Optimised Condition	117
	Analysis of Stoichiometry	117
	Morphology	118
	Structural Analysis	121
V	SUMMARY AND RECOMMENDATION	125
	REFERENCES	129



APPENDICES	134
Appendix A: Sn/S Values for Analysis of	134
Stoichiometry	
Appendix B: X-ray Diffractogram	141
Appendix C: XPS Results	155
Appendix D: In-situ Examination of Deposits:	160
Analysis of Photoresponse	
Appendix E: Estimation of Thickness	165
Appendix F: UV-visible Spectroscopy for	167
Determination of Band Energy	
VITA	222



## LIST OF TABLES

Table		Page
1.1	Bandgap of Sn Binary Compounds Rendering Semiconductive Property.	2
2.1	Elementary, Binary and Ternary Semiconductors with Some Showing Distinguished Properties of Narrow-gap Semiconductor.	15
2.2	Bond Length and Strength of $\alpha$ - and $\beta$ -SnS. Reproduced from [38].	23
2.3	Difference in Lattice Parameters as a Result of Phase Transition. Reproduced from [38].	23
2.4	Dual Property of Optical Transition.	25
2.5	Deduction of Reaction Corresponding to Signals at a Specific Potential.	38
2.6	Deduction of Reaction Corresponding to a Signal at a Specific Potential.	40
3.1	Quantity of Each Solution in the Electrodeposition Bath and Photoelectrochemical (PEC) Test Bath (No. 3).	48
3.2	Variation of Parameters Selected for Systematic Study	50
3.3	Recognition of Peaks in an EDAX Chart.	53
3.4	Determining Sn:S Stoichiometry at x100 Magnification Based Upon Peak Maximum Height and Peak Area.	54
3.5	Demonstrating an Outlier, Q.	55
3.6	Eight Important Regions for Characterisation of a Diffractogram	62
3.7	Specific Binding Energy of Compounds Possibly Present in the Thin Film.	64
4.1	EDAX Analysis for Sn/S Ratios.	69
4.2	Eight Regions of Interest for Characterisation of a Diffractogram	74



4.3	Signal Intensity for Characterisation of Deposits.	75
4.4	EDAX Data for Sn/S Ratio.	78
4.5	Signal Intensity for Characterisation of Deposits.	81
4.6	Signal Intensity for Characterisation of Deposits.	87
4.7	Signal Intensity for Characterisation of Deposits.	91
4.8	Sn/S Ratio from EDAX with Respect to Various Magnifications.	92
4.9	Signal Intensity for Characterisation of Deposits.	98
4.10	Sn/S for Samples Prepared With and Without EDTA	103
4.11	Comparison of Composition from XPS Analysis.	106
4.12	Comparison of E <sub>g</sub> to Optical Tansition.	110
4.13	Sn/S Ratio from EDAX.	117
4.14	XRD Signal Intensity for Characterisation of Deposits.	124



### **LIST OF FIGURES**

Table		Page
2.1	Energy diagram of a semiconductor. The highest filled band forms the valence band while the lowest empty band forms the conduction band. <i>Reproduced from [23]</i> .	7
2.2	Resemblance of band energy of a) metal, b) semiconductor, c) insulators. Reproduced from [2].	9
2.3	Silicon lattice with phosphorus as dopant. The resulting conductivity is of n-type. <i>Reproduced from [23]</i> .	11
2.4	Silicon lattice with boron as dopant. The resulting conductivity is of p-type. Reproduced from [23].	13
2.5	Occurrence of direct and indirect transitions in a compound semiconductor, GaAs. Reproduced from [27].	14
2.6	"Stabilised Efficiency" what makes a-Si remains of great importance. Reproduced from [27].	17
2.7	Efficiency of a-Si, CdTe and CIS from 1976 to 1994. Reproduced from [27].	18
2.8	Atomic mass, Z, versus ionity. Reproduced from [32].	20
2.9	Electron distributions in SnS a) original electron distribution b) density of redistributed electrons. Reproduced from [32].	21
2.10	Distortion of a rocksalt structure to an arsen-like structure to illustrate the similar transition of $\alpha$ -SnS to $\beta$ -SnS. Reproduced from [32].	22
2.11	$\alpha$ -SnS is a distortion of $\beta$ -SnS with positional shift of the Sn atoms of approximately 0.4 angstrom along x-axis. <i>Reproduced from [38]</i> .	24
2.12	Cyclic voltammogram of NaHCO <sub>3</sub> and NaS <sub>2</sub> at tin electrode. <i>Reproduced from [44].</i>	36
2.13	Cyclic voltammogram corresponding to the reactions in Table 2.6.  Reproduced from [21].	41



3 1	Side view of the electrodeposition cell showing the relative position of all electrodes	43
3 2	Experimental setup for electrodeposition of SnS	43
3 3	Front view and cross-sectional view of the holder of titanium substrate	45
3 4	EDAX chart of SnS standard of 96% purity	53
3 5	Top view of the sample deposit prepared on titanium substrate and regions of analysis with respect to magnification	57
3 6	Cleft and tilted titanium substrate placed on the stub in the microanalytic unit	59
3 7	Differentiation between a) direct and b) indirect optical transitions from the A versus $\lambda$ output Note the different $\lambda$ range Reproduced from [20]	67
4 1	Dotplot of Sn/S ratios The two thiosulphate concentration extremes render values beyond the border of acceptable range	<b>7</b> 0
4 2	Control chart showing Sn/S ratios versus stannous ion concentration in the electrodeposition bath	77
4 3	Control chart showing Sn/S ratios versus Sn-EDTA concentration in the electrodeposition bath	83
4 4	Large difference in composition when region of analysis is extended	83
4 5	Sn/S distribution at various magnification	84
4 6	Control chart showing Sn/S ratios versus EDTA concentrations in the electrodeposition bath	89
47	Sn/S ratios from EDAX against electrodeposition potential	93
4 8	Cyclic voltammogam of an earlier study by Zulkarnain and coworkers Reproduced from [21]	97
4 9	The graph of I <sub>max</sub> -I <sub>dk®</sub> For method of Determination, refer Appendix D2	100



4.10	Photoactivity a) I <sub>max</sub> versus Sample Number b) I <sub>max</sub> versus Electrodeposition Potential.	101
4.11	Photoacticivity a) $I_{ph}$ - $I_{dk(f)}$ versus Electrodeposition Potential and b) $I_{max}$ - $I_{dk@}$ versus Electrodeposition Potential.	102
4.12	The best expected EDAX chart.	104
4.13	X-ray diffractogram of sample prepared without EDTA.	114
4.14	X-ray diffractogram of sample prepared in the presence of EDTA is a confirmation of a significant amount of SnS being present.	114
4.15	The best expected photoresponse of deposits prepared I the absence of EDTA. Refer Appendix D2 for comparison to the best-expected photoresponse of deposits prepared in the presence of EDTA.	115
4.16	Control chart of Sn/S values	118
4.17	X-ray diffractograms of sample prepared in tartaric acid.	121
4.18	X-ray diffractogram of sample prepared in the presence of SDS	122



### LIST OF PLATES

Table		Page
3.1	Different undeposited electrode surface	46
3.2	Amount of deposits with variation in deposition period	52
3.3	The cleft Ti surface of deposited titanium at x230 magnification. Thickness was estimated between 10-100 $\mu$ m. This uncertainty is due to insufficient contrast between Ti/Ti(45°)/SnS(45°)/SnS surface layers.	60
4.1	SEM of samples prepared at thiosulphate concentration extremes.	73
4.2	SEM captured at x1000 magnification.	80
4.3	SEM at x1000 and x6500 magnifications of samples prepared at three Sn-EDTA concentrations; a) and b) 0.85 mM, c) and d) 1.35 mM, e) and f) 2.55 mM.	86
4.4	SEM of deposits prepared at three different EDTA concentrations captured at x20 000 magnification.	90
4.5	SEM of sample prepared at varying potential.	96
4.6	Difference in morphology of deposits synthesised in the presence of EDTA (a, b and c) and deposits synthesised in the absence of EDTA (d, e and f).	109
4.7	SEM of deposits prepared in the presence ((i), (ii) and (iii)) and absence ((iv), (v) and (vi)) of tartaric acid.	120
4.8	SEM of Deposits prepared in SDS.	121



#### LIST OF ABBREVIATIONS

A Absorbance

AE Auxilary electrode

a-Si Amorphous silicon

CE Counter electrode

CIS Copper indium diselenide

CV Cyclic voltammetry/voltammogram

E Potential in volts

E<sub>dep</sub> Deposition potential

EDAX Energy dispersive analysis of x-ray

EDTA Ethyl diamine tetra acetic acid

E<sub>g</sub> Energy gap

eV Electron volts

FF Fill factor

I<sub>dark</sub> Dark current

I<sub>max</sub> Current maximum

I<sub>photo</sub> Photocurrent

ITO Indium doped tin oxide

JCPDS Joint committee on Powder Diffraction Standard

LCL Lower control limit

LSV Linear scan voltammetry/voltammogram



LSPV Linear scan photovoltammetry

 $M^{n+}$  Metal ion with n charge, where n=1,2,3, etc.

PEC Photoelectrochemical analysis

PVC Polyvinyl chloride

Q Outlier (statistical term)

σ Standard deviation (statistical term)

SCE Saturated calomel electrode

SDS Sodium dodecyl sulfate

SEM Scanning electron microscopy

μ Mean (Statistical term)

μpdsm Micro powder data search match

UCL Upper control limit

UKM Universiti Kebangsaan Malaysia

UM Universiti Malaya

UPM Universiti Putra Malaysia

USM Universiti Sains Malaysia

2θ Two theta

WE Working electrode

W<sub>p</sub> Watt power

XPS X-ray photoelectron spectroscopy

XRD X-ray diffraction



#### **CHAPTER I**

#### INTRODUCTION

The era of science and technology will be left for the ionic and protonic technology, by which this work is motivated. Reducing the dimensions of devices is one of the aspects in focus [1]. One of the works prompted by this is the development of thin films from which the idea of electrochemical technique stems for the synthesis of tin sulphide, SnS. This phase of Sn-S compounds reveals the features of an ideal semiconductor with E<sub>g</sub> falling in the range of 1-2 eV (Table 1.1), making it suitable for photoelectrochemical, photovoltaic and optoelectronic applications, for instance.

The thin film form of SnS and other more common binary compounds such as CdS, GaAs, ZnS, ZnSe and CdSe, capture a significant interest of scientists in many fields, vis-a-vis Energy, Solar Cell Devices, Silicon and Tin Technology, Materials, Chemistry Electronic Industry and etceteras. In Malaysia, thin film technology is one of the most important technologies in the electronic industry to account for its being world's third largest exporter of semiconductor. With Sn and Si abundance, Malaysia is in even better position for the world market of USD100 billion for thin film [1].

